

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/843,197	CHIU ET AL.	
Examiner		Art Unit		Page 1 of 1
Cong-Lac Huynh		2178		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,418,457	07-2002	Schmidt et al.	715/512
*	B	US-2002/0010708	01-2002	McIntosh, Lowrie	707/500
*	C	US-2002/0073114	06-2002	Nicastro et al.	707/500
*	D	US-2001/0034738	10-2001	Cantwell et al.	707/500
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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